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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/667,466	HEISMANN ET AL.	
Examiner	Art Unit	
Faye Polyzos	2884	

SEARCHED				
Class	Subclass	Date	Examiner	
250	370.11	Updoted 2/28/2006	FP	
250	370.09	2/28/2006	FP	
250	370.08	2/28/2006	FP	
250	363.01	2/28/2006	FP	
250	361R	2)28/2006	FP	
250	368	2/28/2006	FP	
250	332	2/28/2006	FP	
250	339.02	2/28/2006	FP	
378	19	UpcloWi 2/28/2006	FP	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
PGPub	Text Srch	2/28/2006	FP	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US-PGPUB,USPAT,EPO,JPO, DERWENT) See Search History Printout	2/28/2006	FP		
Interference Search History Printout	2/28/2006	FP		